Se	arch No	otes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/697,236	MIKURIYA ET AL.	
Examiner	Art Unit	
Mark A. Chapman	1756	

SEARCHED			
Class	Subclass	Date	Examiner
430	108.2	5/27/2005	MC
	108.8		
	109.1		
	109.4		
upda	te	11/05	ne
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
430	108.2	wc.	nic
	108.8	11/02	
	109.1		
	109.4		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
east	5/27/2005	мс
ydete	11/05.	برد